

Test Report

Report No.: MTi240306004-06E3

Date of issue: 2024-04-16

Applicant: SHENZHEN YLW TECHNOLOGY CO., LTD.

Product: Ice Brick Series Clear Game Controller

MG35, MG25, MG25Z, MG35Z, MG36, MG36Z, Model(s):

MG63, MG64, MG65, MG37

FCC ID: 2AYRM-MG35

Shenzhen Microtest Co., Ltd.

http://www.mtitest.cn



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Test Result Certification			
Applicant:	SHENZHEN YLW TECHNOLOGY CO., LTD.		
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Manufacturer:	SHENZHEN YLW TECHNOLOGY CO., LTD.		
Address:	1F, Building 2, WanYan Industrial Park, Chongqing Rd, QiaoTou, FuYong, Baoan, Shenzhen, China		
Product description			
Product name:	Ice Brick Series Clear Game Controller		
Trade mark:	N/A		
Model name:	MG35		
Series Model(s):	MG25, MG25Z, MG35Z, MG36, MG36Z, MG63, MG64, MG65, MG37		
Standards:	47 CFR Part 15.247		
Test Method:	KDB 558074 D01 15.247 Meas Guidance v05r02 ANSI C63.10-2020		
Date of Test			
Date of test:	2024-04-09 to 2024-04-16		
Test result:	Pass		

Test Engineer :	:	James Qin
		(James Qin)
Reviewed By	:	Dowid. Cee
		(David Lee)
Approved By	:	leon chen
		(Leon Chen)



1 General Description

1.1 Description of the EUT

Product name:	Ice Brick Series Clear Game Controller
Model name:	MG35
Series Model(s):	MG25, MG25Z, MG35Z, MG36, MG36Z, MG63, MG64, MG65, MG37
Model difference:	All the models are the same circuit and module, except the model name and color.
Electrical rating:	Input: DC5V 500mA Battery:3.7V 600mAh
Accessories:	N/A
Hardware version:	YLW-G35Z—Main
Software version:	V1.0.2
Test sample(s) number:	MTi240306004-06S1001
RF specification	
Operating frequency range:	2402-2480
Channel number:	79
Modulation type:	GFSK
Antenna(s) type:	PCB ANT
Antenna(s) gain:	2.88dBi

1.2 Description of test modes

No.	Emission test modes
Mode1	TX-GFSK

1.2.1 Operation channel list

Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
0	2402	20	2422	40	2442	60	2462
1	2403	21	2423	41	2443	61	2463
2	2404	22	2424	42	2444	62	2464
3	2405	23	2425	43	2445	63	2465
4	2406	24	2426	44	2446	64	2466
5	2407	25	2427	45	2447	65	2467
6	2408	26	2428	46	2448	66	2468
7	2409	27	2429	47	2449	67	2469
8	2410	28	2430	48	2450	68	2470
9	2411	29	2431	49	2451	69	2471
10	2412	30	2432	50	2452	70	2472

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11	2413	31	2433	51	2453	71	2473
12	2414	32	2434	52	2454	72	2474
13	2415	33	2435	53	2455	73	2475
14	2416	34	2436	54	2456	74	2476
15	2417	35	2437	55	2457	75	2477
16	2418	36	2438	56	2458	76	2478
17	2419	37	2439	57	2459	77	2479
18	2420	38	2440	58	2460	78	2480
19	2421	39	2441	59	2461	-	-

Test Channel List

Operation Band: 2400-2483.5 MHz

.							
Bandwidth Lowest Channel (LCH)		Middle Channel (MCH)	Highest Channel (HCH)				
(MHz)	(MHz)	(MHz)	(MHz)				
1	2402	2441	2480				

Note: The test software provided by manufacturer is used to control EUT for working in engineering mode, that enables selectable channel, and capable of continuous transmitting mode.

Test Software: FCCTestTool V2.2

For power setting, refer to below table.

Mode	2402MHz	2441MHz	2480MHz
GFSK	5	5	5



1.3 Environmental Conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature:	15°C ~ 35°C
Humidity:	20% RH ~ 75% RH
Atmospheric pressure:	98 kPa ~ 101 kPa

1.4 Description of support units

Support equipment list						
Description Model		Serial No.	Manufacturer			
Adapter	Adapter XY-PQ018E1		Dongguan Xu Yuan Electronic Technology Co., Ltd			
Support cable list						
Description Length (m)		From	То			
/	/ /		/			

1.5 Measurement uncertainty

Measurement	Uncertainty
Conducted emissions (AMN 150kHz~30MHz)	±3.1dB
Occupied channel bandwidth	±3 %
RF output power, conducted	±1 dB
Time	±1 %
Unwanted Emissions, conducted	±1 dB
Radiated spurious emissions (above 1GHz)	±5.3dB
Radiated spurious emissions (9kHz~30MHz)	±4.3dB
Radiated spurious emissions (30MHz~1GHz)	±4.7dB
Temperature	±1 °C
Humidity	±5%

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

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2 Summary of Test Result

No.	Item	Standard	Requirement	Result
1	Antenna requirement	47 CFR Part 15.247	47 CFR 15.203	Pass
2	Conducted Emission at AC power line	47 CFR Part 15.247	47 CFR 15.207(a)	Pass
3	Occupied Bandwidth	47 CFR Part 15.247	47 CFR 15.215(c)	Pass
4	Maximum Conducted Output Power	47 CFR Part 15.247	47 CFR 15.247(b)(1)	Pass
5	Channel Separation	47 CFR Part 15.247	47 CFR 15.247(a)(1)	Pass
6	Number of Hopping Frequencies	47 CFR Part 15.247	47 CFR 15.247(a)(1)(iii)	Pass
7	Dwell Time	47 CFR Part 15.247	47 CFR 15.247(a)(1)(iii)	Pass
8	RF conducted spurious emissions and band edge measurement	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
9	Band edge emissions (Radiated)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
10	Radiated emissions (below 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
11	Radiated emissions (above 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass



3 Test Facilities and accreditations

3.1 Test laboratory

Test laboratory:	Shenzhen Microtest Co., Ltd.				
Test site location:	101, No.7, Zone 2, Xinxing Industrial Park, Fuhai Avenue, Xinhe Community, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China				
Telephone:	(86-755)88850135				
Fax:	(86-755)88850136				
CNAS Registration No.:	CNAS L5868				
FCC Registration No.:	448573				
IC Registration No.:	21760				
CABID:	CN0093				



4 List of test equipment

No.	Equipment	Manufacturer	Model	Serial No.	Cal. date	Cal. Due			
		Conducted En	nission at AC po	wer line	,				
1	EMI Test Receiver	Rohde&schwarz	ESCI3	101368	2023-04-26	2024-04-25			
2	Artificial mains network	Schwarzbeck	NSLK 8127	183	2023-05-05	2024-05-04			
3	Artificial Mains Network	Rohde & Schwarz	ESH2-Z5	100263	2023-06-03	2024-06-02			
		Emissions in non- Occu Maximum Co Chan	Dwell Time -restricted freque pied Bandwidth onducted Output anel Separation Hopping Freque	Power					
1	Wideband Radio Communication Tester	Rohde&schwarz	CMW500	149155	2023-04-26	2024-04-25			
2	ESG Series Analog Ssignal Generator	Agilent	E4421B	GB40051240	2023-04-25	2024-04-24			
3	PXA Signal Analyzer	Agilent	N9030A	MY51350296	2023-04-25	2024-04-24			
4	Synthesized Sweeper	Agilent	83752A	3610A01957	2023-04-25	2024-04-24			
5	MXA Signal Analyzer	Agilent	N9020A	MY50143483	2023-04-26	2024-04-25			
6	RF Control Unit	Tonscend	JS0806-1	19D8060152	2023-04-26	2024-04-25			
7	Band Reject Filter Group	Tonscend	JS0806-F	19D8060160	2023-05-05	2024-05-04			
8	ESG Vector Signal Generator	Agilent	N5182A	MY50143762	2023-04-25	2024-04-24			
9	DC Power Supply	Agilent	E3632A	MY40027695	2023-05-05	2024-05-04			
		Band edge Emissions in freq	emissions (Radi uency bands (ab	,					
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2023-04-26	2024-04-25			
2	Double Ridged Broadband Horn Antenna	schwarabeck	BBHA 9120 D	2278	2023-06-17	2025-06-16			
3	Amplifier	Agilent	8449B	3008A01120	2023-06-26	2024-06-25			
4	Multi-device Controller	TuoPu	TPMDC	/	2023-05-04	2024-05-03			
5	MXA signal analyzer	Agilent	N9020A	MY54440859	2023-06-01	2024-05-31			
	Emissions in frequency bands (below 1GHz)								
1	EMI Test Receiver	Rohde&schwarz	ESCI7	101166	2023-04-26	2024-04-25			
2	TRILOG Broadband Antenna	schwarabeck	VULB 9163	9163-1338	2023-06-11	2025-06-10			
3	Active Loop Antenna	Schwarzbeck	FMZB 1519 B	00066	2023-06-11	2025-06-10			
4	Amplifier	Hewlett-Packard	8447F	3113A06184	2023-04-25	2024-04-24			
5	Multi-device Controller	TuoPu	TPMDC	/	2023-05-04	2024-05-03			



5 Evaluation Results (Evaluation)

5.1 Antenna requirement

Test Requirement:	Refer to 47 CFR Part 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.
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5.1.1 Conclusion:

The antenna of the EUT is permanently attached.

The EUT complies with the requirement of FCC PART 15.203.



6 Radio Spectrum Matter Test Results (RF)

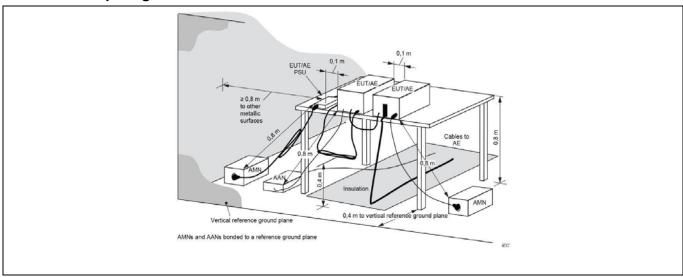
6.1 Conducted Emission at AC power line

Test Requirement:	Refer to 47 CFR 15.207(a), Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μ H/50 ohms line impedance stabilization network (LISN).						
Test Limit:	Frequency of emission (MHz) Conducted limit (dBµV)						
		Quasi-peak	Average				
	0.15-0.5	66 to 56*	56 to 46*				
	0.5-5 56 46						
	5-30 60 50						
	*Decreases with the logarithm of the frequency.						
Test Method:	ANSI C63.10-2020 section 6.2						
Procedure:	Refer to ANSI C63.10-2020 section 6.2, standard test method for ac power- line conducted emissions from unlicensed wireless devices						

6.1.1 E.U.T. Operation:

Operating Envi	Operating Environment:								
Temperature:	Temperature: 24 °C Humidity: 59 % Atmospheric Pressure: 100 kPa								
Pre test mode:	Pre test mode: Mode1								
Final test mode	Final test mode: Mode1								

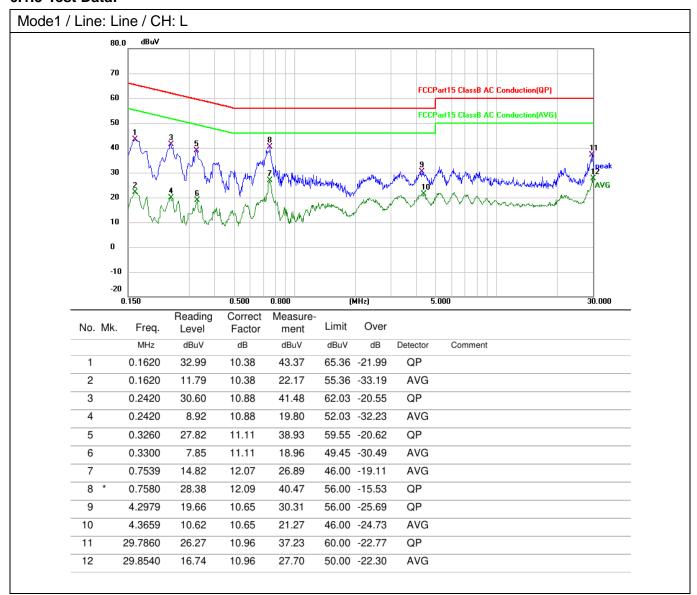
6.1.2 Test Setup Diagram:



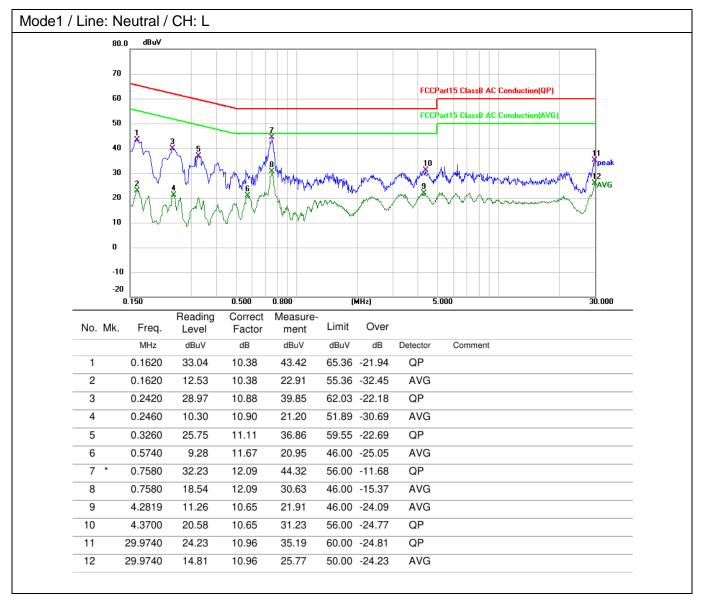
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6.1.3 Test Data:









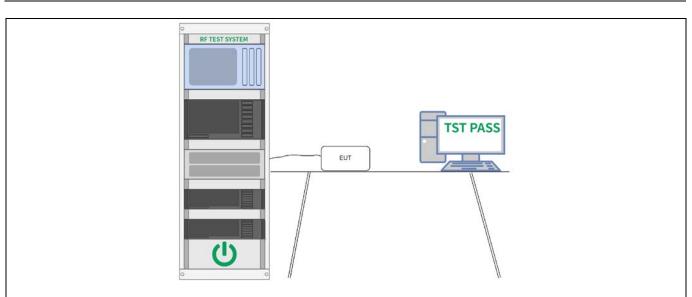
6.2 Occupied Bandwidth

Test Deguirement	
Test Requirement:	47 CFR 15.215(c)
Test Limit:	Refer to 47 CFR 15.215(c), intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
Test Method:	ANSI C63.10-2020, section 7.8.6, For occupied bandwidth measurements, use the procedure in 6.9.3. Frequency hopping shall be disabled for this test. KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The occupied bandwidth is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers are each equal to 0.5% of the total mean power of the given emission. The following procedure shall be used for measuring 99% power bandwidth: a) The instrument center frequency is set to the nominal EUT channel center frequency. The frequency span for the spectrum analyzer shall be between 1.5 times and 5.0 times the OBW. b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW, and VBW shall be at least three times the RBW, unless otherwise specified by the applicable requirement. c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.6.2. d) Step a) through step c) might require iteration to adjust within the specified range. e) Video averaging is not permitted. Where practical, a sample detection and single sweep mode shall be used. Otherwise, peak detection and max-hold mode (until the trace stabilizes) shall be used. f) Use the 99% power bandwidth function of the instrument (if available) and report the measured bandwidth. g) If the instrument does not have a 99% power bandwidth function, then the trace data points are recovered and directly summed in linear power terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5% of the total is reached; that frequency is recorded as the lower frequency. The process is repeated until 99.5% of the total is reached; that frequency is recorded as the upper frequency. The 99% power bandwidth is the difference between these two frequencies. h) The occupied bandwidth shall be reported by providing spectral plot(s) of the measuring instrument display; the plot axes and the scale units per division shall be clearl

6.2.1 E.U.T. Operation:

Operating Environment:								
Temperature:	Temperature: 24 °C Humidity: 59 % Atmospheric Pressure: 100 kPa							
Pre test mode:	Pre test mode: Mode1							
Final test mode: Mod		Mode	e1					

6.2.2 Test Setup Diagram:



6.2.3 Test Data:



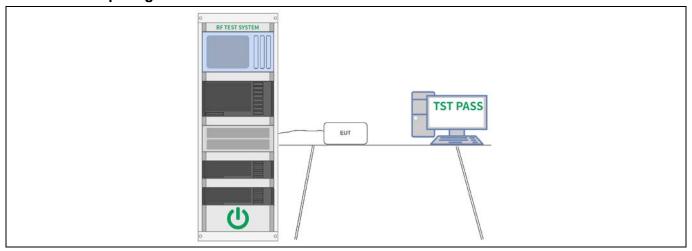
6.3 Maximum Conducted Output Power

Test Requirement:	47 CFR 15.247(b)(1)
Test Limit:	Refer to 47 CFR 15.247(b)(1), For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Test Method:	ANSI C63.10-2020, section 7.8.5 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. Frequency hopping shall be disabled for this test. Use the following spectrum analyzer settings: a) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel. b) RBW > 20 dB bandwidth of the emission being measured. c) VBW ≥ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow trace to stabilize. h) Use the marker-to-peak function to set the marker to the peak of the emission. i) The indicated level is the peak output power, after any corrections for external attenuators and cables. j) A spectral plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth is greater than the occupied bandwidth of the unlicensed wireless device, rather than a spectrum analyzer.

6.3.1 E.U.T. Operation:

Operating Environment:								
Temperature:	Temperature: 24 °C Humidity: 59 % Atmospheric Pressure: 100 kPa							
Pre test mode: Mod			e1					
Final test mode: Mod			e1					

6.3.2 Test Setup Diagram:



6.3.3 Test Data:



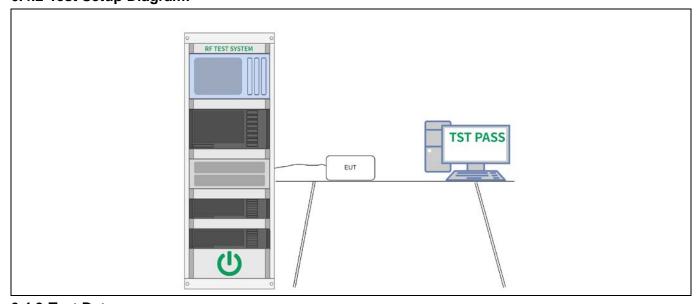
6.4 Channel Separation

Test Requirement:	47 CFR 15.247(a)(1)
Test Limit:	Refer to 47 CFR 15.247(a)(1), Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Test Method:	ANSI C63.10-2020, section 7.8.2 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel. c) Video (or average) bandwidth (VBW) ≥ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A spectral plot of the data shall be included in the test report.

6.4.1 E.U.T. Operation:

Operating Environment:							
Temperature:	Temperature: 24 °C Humidity: 59 % Atmospheric Pressure: 100 kPa						
Pre test mode: Mod		Mode	e1				
Final test mode: Mod		Mode	e1				

6.4.2 Test Setup Diagram:



6.4.3 Test Data:



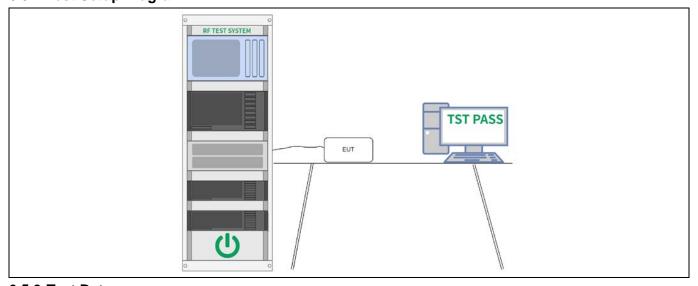
6.5 Number of Hopping Frequencies

Test Requirement:	47 CFR 15.247(a)(1)(iii)
Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	ANSI C63.10-2020, section 7.8.3 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it could be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: No faster than coupled (auto) time. e) Detector function: Peak. f) Trace: Max-hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A spectral plot of the data shall be included in the test report.

6.5.1 E.U.T. Operation:

Operating Envi	ironment:	1				
Temperature:	24 °C		Humidity:	59 %	Atmospheric Pressure:	100 kPa
Pre test mode:		Mode	e1			
Final test mode	e:	Mode	e1			

6.5.2 Test Setup Diagram:



6.5.3 Test Data:



6.6 Dwell Time

Test Requirement:	47 CFR 15.247(a)(1)(iii)
Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Test Method:	ANSI C63.10-2020, section 7.8.4 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	The dwell time per hop on a channel is the time from the start of the first transmission to the end of the last transmission for that hop. If the device has a single transmission per hop then the dwell time is the duration of that transmission. If the device has a multiple transmissions per hop then the dwell time is measured from the start of the first transmission to the end of the last transmission.
	The time of occupancy is the total time that the device dwells on a channel over an observation period specified in the regulatory requirement. To determine the time of occupancy the spectrum analyzer will be configured to measure both the dwell time per hop and the number of times the device transmits on a specific channel in a given period.
	The EUT shall have its hopping function enabled. Compliance with the requirements shall be made with the minimum and with the maximum number of channels enabled. If the dwell time per channel does not vary with the number of channels than compliance with the requirements may be based on the minimum number of channels. If the device supports different dwell times per channel (example Bluetooth devices can dwell on a channel for 1, 3 or 5 time slots) then measurements can be limited to the longest dwell time with the minimum number of channels.
	Use the following spectrum analyzer settings to determine the dwell time per hop:
	 a) Span: Zero span, centered on a hopping channel. b) RBW shall be ≤ channel spacing and where possible RBW should be set >> 1 / T, where T is the expected transmission time per hop. c) Sweep time: Set so that the start of the first transmission and end of the last transmission for the hop are clearly captured. Setting the sweep time to be slightly longer than the hopping period per channel (hopping period = 1/hopping rate) should achieve this. d) Use a video trigger, where possible with a trigger delay, so that the start of the transmission is clearly observed. The trigger level might need adjustment to reduce the chance of triggering when the system hops on an adjacent channel. e) Detector function: Peak. f) Trace: Clear-write, single sweep. g) Place markers at the start of the first transmission on the channel and at the end of the last transmission. The dwell time per hop is the time between these two markers.
	To determine the number of hops on a channel in the regulatory observation period repeat the measurement using a longer sweep time. When the device uses a single hopping sequence the period of measurement should be



sufficient to capture at least 2 hops. When the device uses a dynamic hopping sequence, or the sequence varies, the period of measurement may need to capture multiple hops to better determine the average time of occupancy. Count the number of hops on the channel across the sweep time.

Report No.: MTi240306004-06E3

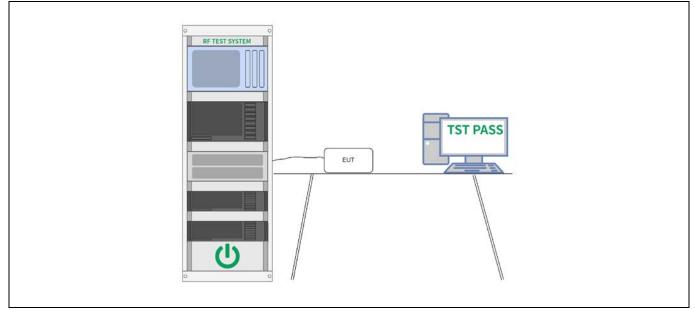
The average number of hops on the same channel within the regulatory observation period is calculated from the number of hops on the channel divided by the spectrum analyzer sweep time multiplied by the regulatory observation period. For example, if three hops are counted with an analyzer sweep time of 500 ms and the regulatory observation period is 10 s, then the number of hops in that ten seconds is $3/0.5 \times 10$, or 60 hops.

The average time of occupancy is calculated by multiplying the dwell time per hop by the number of hops in the observation period.

6.6.1 E.U.T. Operation:

Operating Envi	ronment:	1				
Temperature:	24 °C		Humidity:	59 %	Atmospheric Pressure:	100 kPa
Pre test mode:		Mode	e1			
Final test mode	e:	Mode	e1			

6.6.2 Test Setup Diagram:



6.6.3 Test Data:



6.7 RF conducted spurious emissions and band edge measurement

Test Requirement:	47 CFR 15.247(d), 15.209, 15.205
Test Limit:	Refer to 47 CFR 15.247(d), In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.
Test Method:	ANSI C63.10-2020 section 7.8.7 KDB 558074 D01 15.247 Meas Guidance v05r02
Procedure:	7.8.7.1 General considerations To demonstrate compliance with the relative out-of-band emissions requirements conducted spurious emissions shall be measured for the transmit frequencies, per 5.5 and 5.6, and at the maximum transmit powers. Frequency hopping shall be disabled for this test with the exception of measurements at the allocated band-edges which shall be repeated with hopping enabled. Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The frequency range of testing shall span 30 MHz to 10 times the operating frequency and this may be done in a single sweep or, to aid resolution, across a number of sweeps. The resolution bandwidth shall be 100 kHz, video bandwidth 300 kHz, and a coupled sweep time with a peak detector. The limit is based on the highest in-band level across all channels measured using the same instrument settings (resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector). To help clearly demonstrate compliance a display line may be set at the required offset (typically 20 dB) below the highest in-band level. Where the highest in-band level is not clearly identified in the out-of-band measurements a
	separate spectral plot showing the in-band level shall be provided. When conducted measurements cannot be made (for example a device with integrated, non-removable antenna) radiated measurements shall be used. The reference level for determining the limit shall be established by maximizing the field strength from the highest power channel and measuring using the resolution and video bandwidth settings and peak detector as described above. The field strength limit for spurious emissions outside of restricted-bands shall then be set at the required offset (typically 20 dB) below the highest in-band level. Radiated measurements will follow the standards measurement procedures described in Clause 6 with the exception that the resolution bandwidth shall be 100 kHz, video bandwidth 300 kHz, and a coupled sweep time with a peak detector. Note that use of wider measurement bandwidths are acceptable for measuring the spurious emissions provided that the peak detector is used and that the measured value of spurious emissions are compared to the highest in-band level measured with the 100 kHz / 300 kHz bandwidth settings to determine compliance.

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7.8.7.2 Band-edges

Compliance with a relative limit at the band-edges (e.g., -20 dBc) shall be made on the lowest and on the highest channels with frequency hopping disabled and repeated with frequency hopping enabled. For the latter test the hopping sequence shall include the lowest and highest channels.

Report No.: MTi240306004-06E3

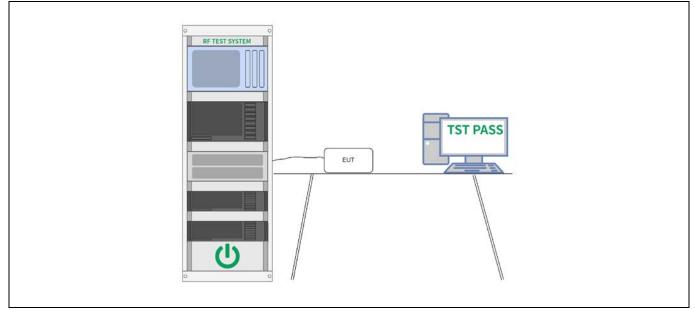
For measurements with the hopping disabled the analyzer screen shall clearly show compliance with the requirement within 10 MHz of the allocated band-edge.

For measurements with the hopping enabled the analyzer screen shall clearly show compliance with the requirement within 10 MHz of both of the allocated band-edges. This could require separate spectral plots for each band-edge.

6.7.1 E.U.T. Operation:

Operating Env	ironment:	1				
Temperature:	24 °C		Humidity:	59 %	Atmospheric Pressure:	100 kPa
Pre test mode:		Mode	e1			
Final test mode	e:	Mode	e1			

6.7.2 Test Setup Diagram:



6.7.3 Test Data:



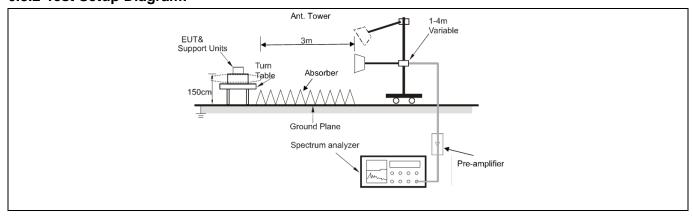
6.8 Band edge emissions (Radiated)

Test Requirement:	restricted bands, as de	7(d), In addition, radiated em fined in § 15.205(a), must al s specified in § 15.209(a)(se	so comply with the
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
	intentional radiators op frequency bands 54-72 However, operation wi sections of this part, e. In the emission table a The emission limits sh employing a CISPR qu kHz, 110-490 kHz and	in paragraph (g), fundamental perating under this section show that, 76-88 MHz, 174-216 thin these frequency bands is g., §§ 15.231 and 15.241. bove, the tighter limit applies own in the above table are basi-peak detector except for above 1000 MHz. Radiated on measurements employing	all not be located in the MHz or 470-806 MHz. s permitted under other at the band edges. ased on measurements the frequency bands 9–90 emission limits in these
Test Method:	ANSI C63.10-2020 sec KDB 558074 D01 15.2	ction 6.10 47 Meas Guidance v05r02	
Procedure:	ANSI C63.10-2020 sec	ction 6.10.5.2	

6.8.1 E.U.T. Operation:

Operating Envi	ironment:	1				
Temperature:	24 °C		Humidity:	59 %	Atmospheric Pressure:	99 kPa
Pre test mode:		Mode	e1			
Final test mode	e:	Mode	e1			
Note:						
The amplitude reported.	of spurio	us em	issions whic	ch are attenuate	ed more than 20 dB belov	v the limits are not

6.8.2 Test Setup Diagram:



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6.8.3 Test Data:

Mode1 /	Polariz	atior	n: Horizonta	al / CH: L					
	No. I	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
	1		2310.000	47.65	-2.66	44.99	74.00	-29.01	peak
	2		2310.000	37.71	-2.66	35.05	54.00	-18.95	AVG
	3		2390.000	48.54	-2.03	46.51	74.00	-27.49	peak
	4	*	2390.000	38.74	-2.03	36.71	54.00	-17.29	AVG

No	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		2310.000	47.35	-2.66	44.69	74.00	-29.31	peak
2		2310.000	38.00	-2.66	35.34	54.00	-18.66	AVG
3		2390.000	48.36	-2.03	46.33	74.00	-27.67	peak
4	*	2390.000	39.38	-2.03	37.35	54.00	-16.65	AVG



Mode1 /	Polariz	atior	n: Horizonta	al / CH: H					
	No. I	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
	1	- 1	2483.500	50.31	-1.91	48.40	74.00	-25.60	peak
	2	:	2483.500	39.61	-1.91	37.70	54.00	-16.30	AVG
	3	- :	2500.000	50.30	-1.80	48.50	74.00	-25.50	peak
	4	*	2500.000	40.17	-1.80	38.37	54.00	-15.63	AVG

No. I	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		2483.500	47.31	-1.91	45.40	74.00	-28.60	peak
2		2483.500	37.66	-1.91	35.75	54.00	-18.25	AVG
3		2500.000	47.00	-1.80	45.20	74.00	-28.80	peak
4	*	2500.000	37.99	-1.80	36.19	54.00	-17.81	AVG



6.9 Radiated emissions (below 1GHz)

Test Requirement:	restricted bands, as de	7(d), In addition, radiated enfined in § 15.205(a), must als specified in § 15.209(a)(se	so comply with the
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
	intentional radiators op frequency bands 54-72 However, operation with sections of this part, e. In the emission table a The emission limits she employing a CISPR qu kHz, 110–490 kHz and	in paragraph (g), fundamental perating under this section show that, 76-88 MHz, 174-216 thin these frequency bands is g., §§ 15.231 and 15.241. bove, the tighter limit applies own in the above table are basi-peak detector except for above 1000 MHz. Radiated on measurements employing	all not be located in the MHz or 470-806 MHz. s permitted under other at the band edges. ased on measurements the frequency bands 9–90 emission limits in these
Test Method:	ANSI C63.10-2020 sec KDB 558074 D01 15.2	ction 6.6.4 47 Meas Guidance v05r02	
Procedure:	ANSI C63.10-2020 sed	ction 6.6.4	

6.9.1 E.U.T. Operation:

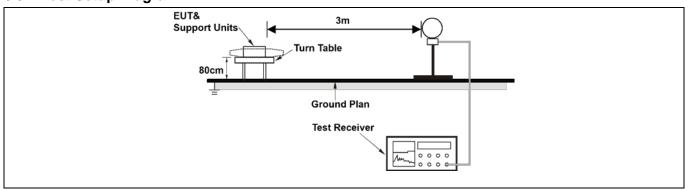
Operating Envi	ronment:	1				
Temperature:	24 °C		Humidity:	59 %	Atmospheric Pressure:	99 kPa
Pre test mode:		Mode	e1			
Final test mode	e:	Mode	e1			
N.I. 4						

Note:

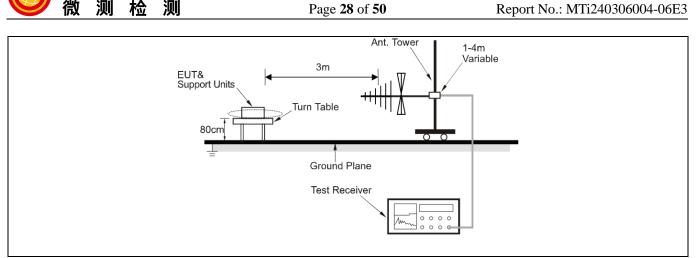
The amplitude of spurious emissions which are attenuated more than 20 dB below the limits are not reported.

All modes of operation of the EUT were investigated, and only the worst-case results are reported. There were no emissions found below 30MHz within 20dB of the limit.

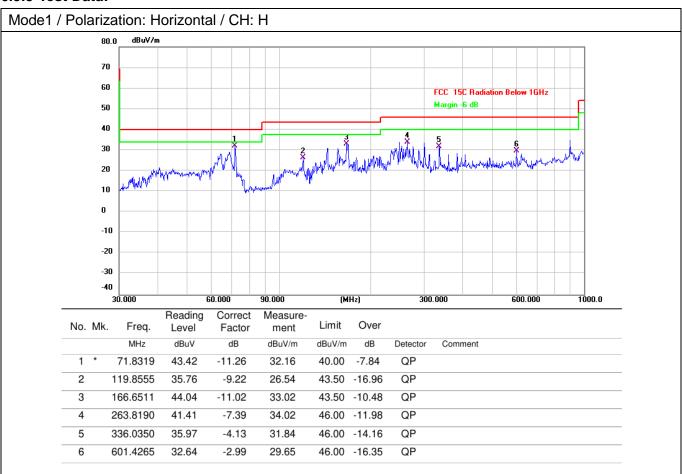
6.9.2 Test Setup Diagram:



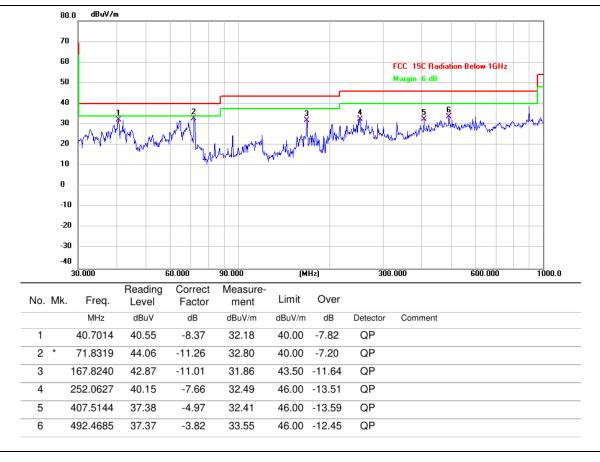
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6.9.3 Test Data:



Mode1 / Polarization: Vertical / CH: H





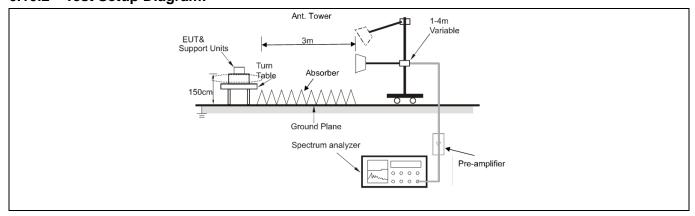
6.10 Radiated emissions (above 1GHz)

Test Requirement:		nissions which fall in the rest comply with the radiated em 5(c)).`	
Test Limit:	Frequency (MHz)	Field strength (microvolts/meter)	Measuremen t distance (meters)
	0.009-0.490	2400/F(kHz)	300
	0.490-1.705	24000/F(kHz)	30
	1.705-30.0	30	30
	30-88	100 **	3
	88-216	150 **	3
	216-960	200 **	3
	Above 960	500	3
	intentional radiators op frequency bands 54-72 However, operation wit sections of this part, e. In the emission table a The emission limits she employing a CISPR qu kHz, 110–490 kHz and	n paragraph (g), fundamental perating under this section shown that the section shows that the section shows the section shows the section shows the section shows the section that the section is section to the section shows the	all not be located in the MHz or 470-806 MHz. s permitted under other at the band edges. ased on measurements the frequency bands 9–90 emission limits in these
Test Method:	ANSI C63.10-2020 sec KDB 558074 D01 15.2	ction 6.6.4 47 Meas Guidance v05r02	
Procedure:	ANSI C63.10-2020 sed	ction 6.6.4	

6.10.1 E.U.T. Operation:

	•					
Operating Env	ironment:					
Temperature:	24 °C		Humidity:	59 %	Atmospheric Pressure:	99 kPa
Pre test mode:		Mode	e1			
Final test mode	e:	Mode	e1			
Note: Test freq	uency are	e from	1GHz to 25	GHz, the a	amplitude of spurious emission	ns which are
attenuated mo	re than 20	dB b	elow the lim	its are not	reported.	
All modes of o	peration of	of the	EUT were ir	vestigated	, and only the worst-case resu	ults are reported.

6.10.2 Test Setup Diagram:



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6.10.3 Test Data:

Mode1 /	Polariz	atio	n: Horizonta	al / CH: L					
	No. I	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
			MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
	1		4804.000	39.26	2.74	42.00	74.00	-32.00	peak
	2		4804.000	32.64	2.74	35.38	54.00	-18.62	AVG
	3		7206.000	37.81	9.34	47.15	74.00	-26.85	peak
	4		7206.000	31.75	9.34	41.09	54.00	-12.91	AVG
	5		9608.000	38.14	10.49	48.63	74.00	-25.37	peak
	6	*	9608.000	31.88	10.49	42.37	54.00	-11.63	AVG

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		4804.000	42.46	2.74	45.20	74.00	-28.80	peak
2		4804.000	36.37	2.74	39.11	54.00	-14.89	AVG
3		7206.000	39.78	9.34	49.12	74.00	-24.88	peak
4		7206.000	33.72	9.34	43.06	54.00	-10.94	AVG
5		9608.000	39.68	10.49	50.17	74.00	-23.83	peak
6	*	9608.000	33.62	10.49	44.11	54.00	-9.89	AVG



No	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		4882.000	41.64	3.07	44.71	74.00	-29.29	peak
2		4882.000	35.38	3.07	38.45	54.00	-15.55	AVG
3		7323.000	38.39	9.03	47.42	74.00	-26.58	peak
4		7323.000	32.26	9.03	41.29	54.00	-12.71	AVG
5		9764.000	39.25	12.03	51.28	74.00	-22.72	peak
6	*	9764.000	33.08	12.03	45.11	54.00	-8.89	AVG

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		4882.000	37.59	3.07	40.66	74.00	-33.34	peak
2		4882.000	31.26	3.07	34.33	54.00	-19.67	AVG
3		7323.000	36.00	9.03	45.03	74.00	-28.97	peak
4		7323.000	29.16	9.03	38.19	54.00	-15.81	AVG
5		9764.000	37.06	12.03	49.09	74.00	-24.91	peak
6	*	9764.000	30.25	12.03	42.28	54.00	-11.72	AVG



	zatio Mk.	n: Horizonta Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		4960.000	42.00	3.52	45.52	74.00	-28.48	peak
2		4960.000	35.74	3.52	39.26	54.00	-14.74	AVG
3		7440.000	39.33	9.16	48.49	74.00	-25.51	peak
4		7440.000	33.06	9.16	42.22	54.00	-11.78	AVG
5		9920.000	37.60	11.74	49.34	74.00	-24.66	peak
6	*	9920.000	31.34	11.74	43.08	54.00	-10.92	AVG

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector
1		4960.000	44.61	3.52	48.13	74.00	-25.87	peak
2		4960.000	38.59	3.52	42.11	54.00	-11.89	AVG
3		7440.000	41.21	9.16	50.37	74.00	-23.63	peak
4		7440.000	35.16	9.16	44.32	54.00	-9.68	AVG
5		9920.000	40.35	11.74	52.09	74.00	-21.91	peak
6	*	9920.000	33.45	11.74	45.19	54.00	-8.81	AVG



Photographs of the test setup

Refer to Appendix – Setup Photos



Photographs of the EUT

Refer to Appendix - EUT Photos



Appendix



Appendix A: 20dB Emission Bandwidth

Test Result

Test Mode	Antenna	Frequency [MHz]	20db EBW [MHz]
DH5	Ant1	2402	1.323
		2441	1.323
		2480	1.323

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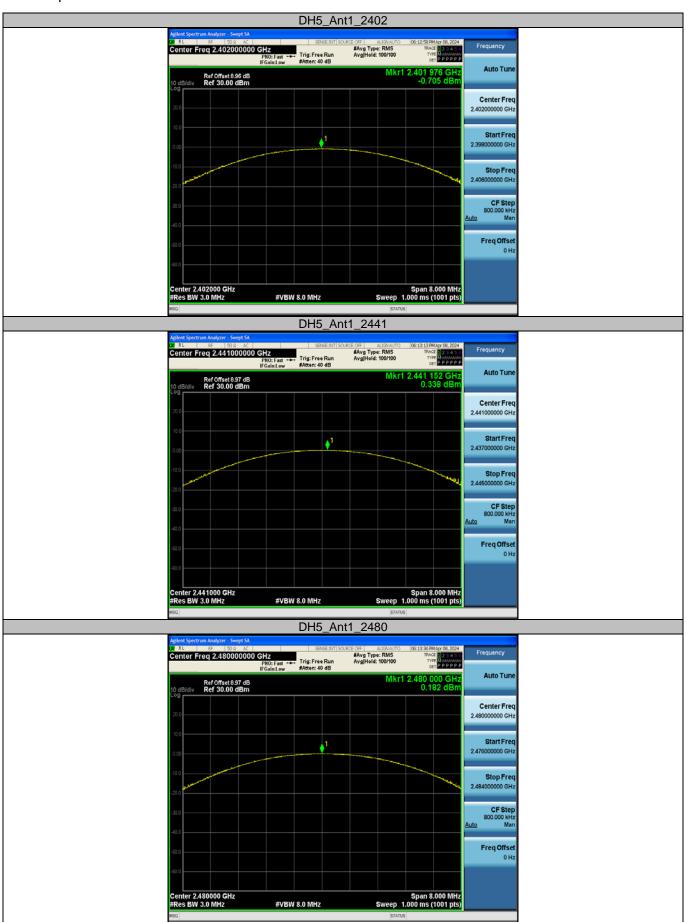
Appendix B: Maximum conducted output power

Test Result Peak

Test Mode	Antenna	Frequency [MHz]	Conducted Peak Power [dBm]	Limit [dBm]	Verdict
DH5	Ant1	2402	-0.71	≤20.97	PASS
		2441	0.34	≤20.97	PASS
		2480	0.18	≤20.97	PASS

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Appendix C: Carrier frequency separation

Test Result

Test Mode	Antenna	Frequency [MHz]	Result [MHz]	Limit [MHz]	Verdict
DH5	Ant1	Нор	1	≥0.882	PASS

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Appendix D: Time of occupancy

Test Result

Test Mode	Antenna	Frequency [MHz]	BurstWidth [ms]	Hops in 31.6s [Num]	Result [s]	Limit [s]	Verdict
DH5	Ant1	Нор	0.431	551	0.237	≤0.4	PASS

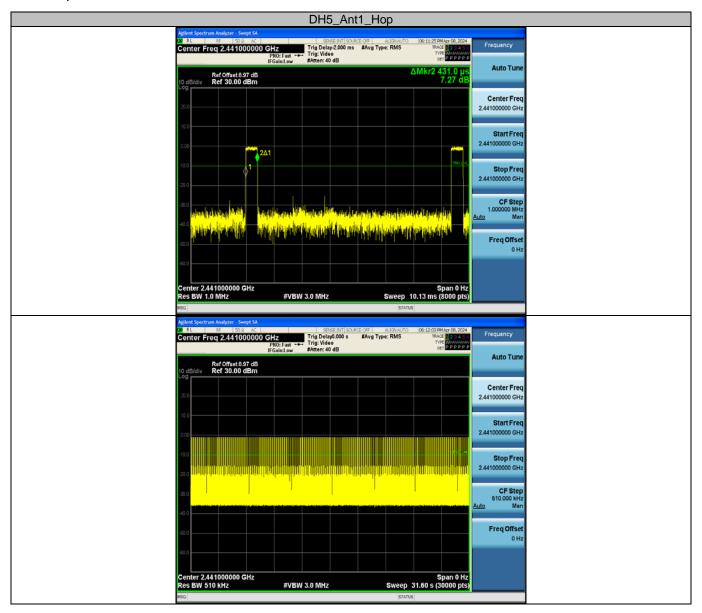
Notes:

- 1. Period time = 0.4s * 79 = 31.6s
- 2. Result (Time of occupancy) = BurstWidth[ms] * Hops in 31.6s [Num]

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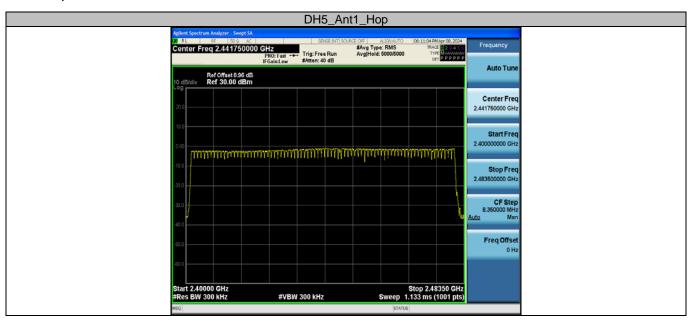




Appendix E: Number of hopping channels

Test Result

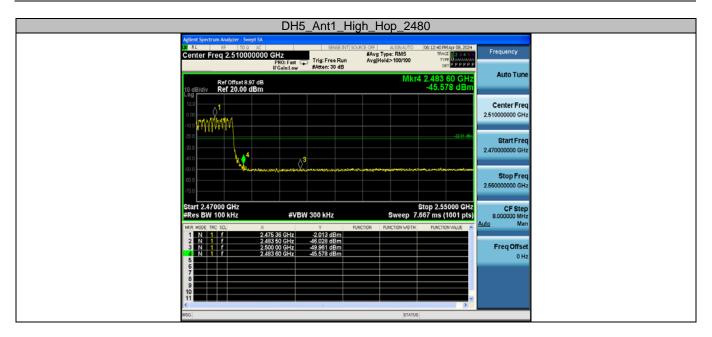
Test Mode	Antenna	Frequency [MHz]	Result [Num]	Limit [Num]	Verdict
DH5	Ant1	Нор	79	≥15	PASS





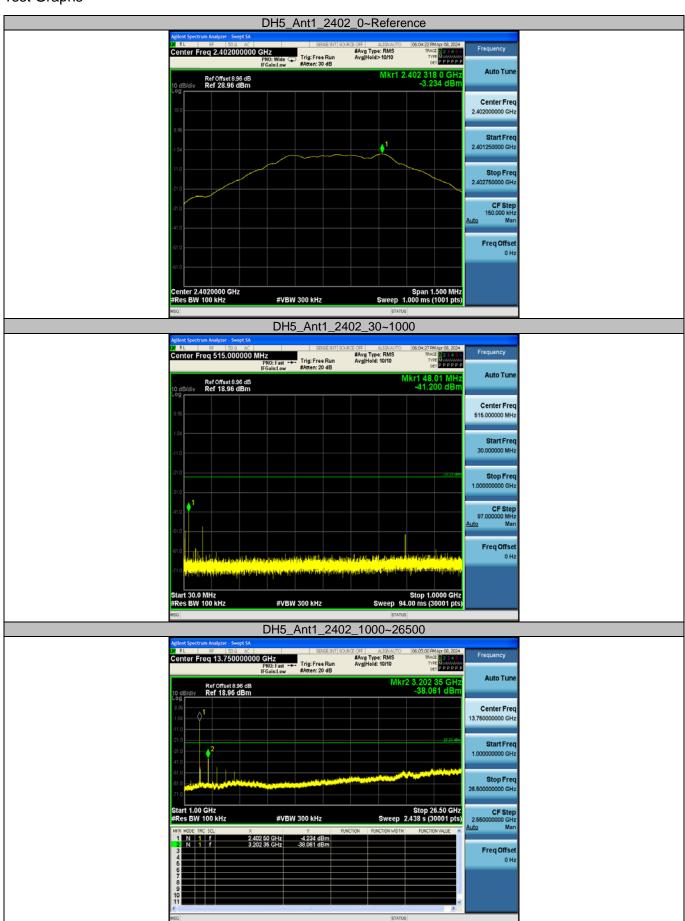
Appendix F: Band edge measurements



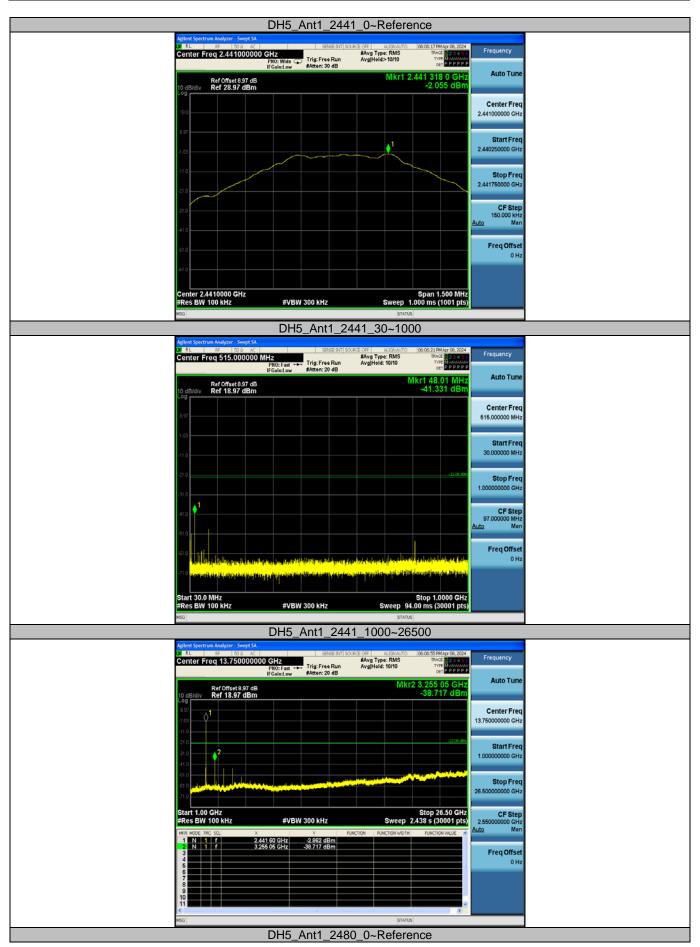


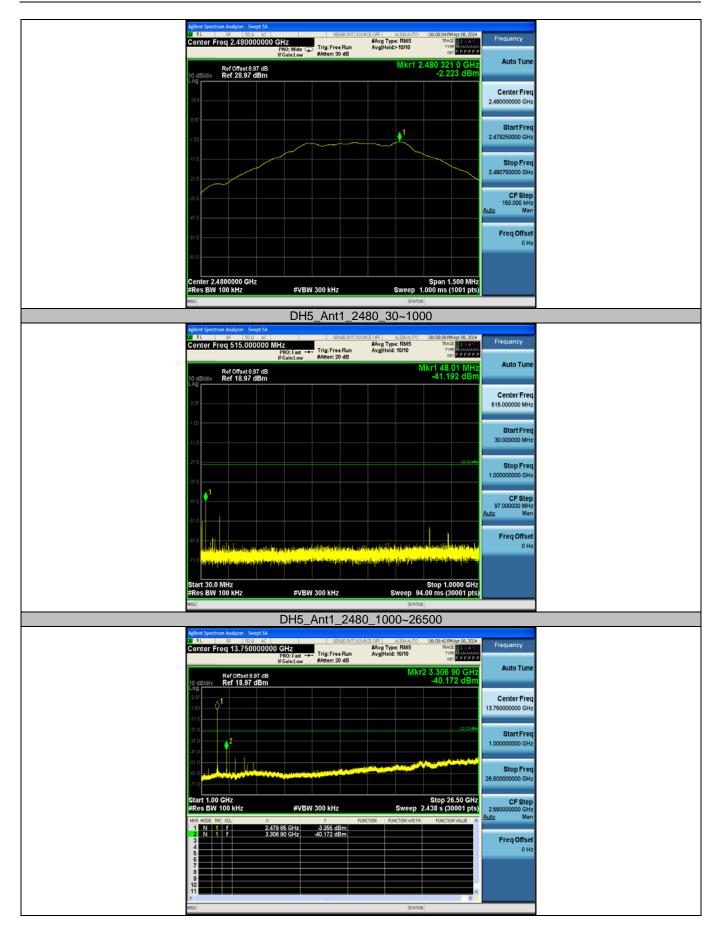


Appendix G: Conducted Spurious Emission









----End of Report----